SCBS159E - JANUARY 1991 - REVISED APRIL 2005

- State-of-the-Art *EPIC*-II*B*<sup>™</sup> BiCMOS Design Significantly Reduces Power Dissipation
- Flow-Through Architecture Optimizes PCB Layout
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical V<sub>OLP</sub> (Output Ground Bounce) < 1 V at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C
- High-Impedance State During Power Up and Power Down
- High-Drive Outputs (–32-mA I<sub>OH</sub>, 64-mA I<sub>OL</sub>)
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK), and Plastic (NT) and Ceramic (JT) DIPs

### description

These 10-bit buffers or bus drivers provide a high-performance bus interface for wide data paths or buses carrying parity.

The 3-state control gate is a 2-input AND gate with active-low inputs so that, if either output-enable  $(\overline{OE1} \text{ or } \overline{OE2})$  input is high, all ten outputs are in the high-impedance state. The 'ABT827 provides true data at the outputs.

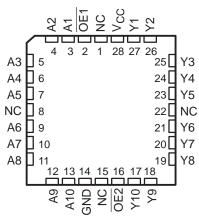
When V<sub>CC</sub> is between 0 and 2.1 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 2.1 V,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

(TOP VIEW)								
	(10		)					
OE1	1	U <sub>24</sub>	Vcc					
A1	2	23	] Y1					
A2	3	22	] Y2					
A3		21	] Y3					
A4		20	] Y4					
A5	6	19	] Y5					
A6	7	18	<b>Y</b> 6					
A7	8	17	] Y7					
A8	9	16	<b>Y</b> 8					
A9	10	15	<b>Y</b> 9					
A10	11	14	Y10					
GND	12	13	OE2					

SN54ABT827 ... JT PACKAGE

SN74ABT827 . . . DB. DW. NT. OR PW PACKAGE

#### SN54ABT827 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

The SN54ABT827 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ABT827 is characterized for operation from –40°C to 85°C.

FUNCTION TABLE							
	INPUTS		OUTPUT				
OE1	OE2	Α	Y				
L	L	L	L				
L	L	Н	н				
н	Х	Х	Z				
Х	Н	Х	Z				



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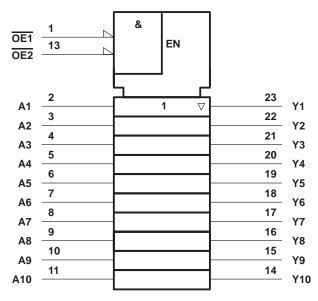
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



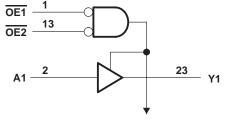
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### logic symbol<sup>†</sup>



logic diagram (positive logic)



**To Nine Other Channels** 

<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the DB, DW, JT, NT, and PW packages.

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>‡</sup>

Supply voltage range, V <sub>CC</sub> Input voltage range, V <sub>I</sub> (see Note 1)		
Voltage range applied to any output in the high		
Current into any output in the low state, $I_{O}$ : SN		
· · · ·		
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)		–18 mA
Output clamp current, $I_{OK}$ (V <sub>O</sub> < 0)		
Package thermal impedance, $\theta_{JA}$ (see Note 2)	: DB package	104°C/W
	DW package	81°C/W
	NT package	67°C/W
		120°C/W
Storage temperature range, T <sub>stg</sub>		–65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.



# SN54ABT827, SN74ABT827 10-BIT BUFFERS/DRIVERS WITH 3-STATE OUTPUTS SCBS159E – JANUARY 1991 – REVISED APRIL 2005

# recommended operating conditions (see Note 3)

		SN54A	BT827	SN74A	BT827	
		MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2		2		V
VIL	Low-level input voltage		0.8		0.8	V
VI	Input voltage	0	VCC	0	VCC	V
IOH	High-level output current		-24		-32	mA
IOL	Low-level output current		48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate		5		5	ns/V
Δt/ΔVCC	Power-up ramp rate	200		200		μs/V
TA	Operating free-air temperature	-55	125	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.



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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		Т	A = 25°0	C	SN54A	BT827	SN74A			
PARAMETER	TEST CONDIT	MIN	TYP†	MAX	MIN	MAX	MIN	MAX	UNIT	
VIK	V <sub>CC</sub> = 4.5 V,	lj = -18 mA			-1.2		-1.2		-1.2	V
	V <sub>CC</sub> = 4.5 V,	I <sub>OH</sub> = -3 mA	2.5			2.5		2.5		
N/	V <sub>CC</sub> = 5 V,	I <sub>OH</sub> = -3 mA	3			3		3		
VOH		OH = -24 mA 2		2				V		
	V <sub>CC</sub> = 4.5 V	I <sub>OH</sub> = -32 mA	2*					2		
		I <sub>OL</sub> = 48 mA			0.55		0.55			
VOL	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 64 mA			0.55*				0.55	V
V <sub>hys</sub>				100						mV
l	$V_{CC} = 0$ to 5.5 V,	$V_I = V_{CC} \text{ or } GND$			±1		±1		±1	μΑ
IOZPU <sup>‡</sup>	$V_{CC}$ = 0 to 2.1 V, $V_{O}$ = 0.5 V	to 2.7 V, OE = X			±50		±10		±50	μΑ
IOZPD <sup>‡</sup>	$V_{CC} = 2.1 \text{ V to } 0, \text{ V}_{O} = 0.5 \text{ V}$	to 2.7 V, OE = X			±50		±10		±50	μA
IOZH	$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V}, \text{ V}_{O} = 2.7 \text{ V}$	7 V, OE ≥ 2 V			10§		10		10§	μA
IOZL	$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V}, \text{ V}_{O} = 0.5 \text{ V}$	5 V, OE ≥ 2 V			–10§		-10		–10§	μΑ
loff	$V_{CC} = 0,$	$V_{I} \text{ or } V_{O} \leq 5.5 \text{ V}$			±100				±100	μΑ
ICEX	$V_{CC} = 5.5 \text{ V}, \text{ V}_{O} = 5.5 \text{ V}$	Outputs high			50		50		50	μΑ
۱ <sub>0</sub> ¶	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.5 V	-50	-140	–225§	-50	–225§	-50	–225§	mA
		Outputs high		80	250		250		250	μA
ICC	$V_{CC} = 5.5 \text{ V}, I_O = 0,$ VI = V <sub>CC</sub> or GND	Outputs low		35	40§		40§		40§	mA
		Outputs disabled		80	250		250		250	μA
	$V_{CC} = 5.5 V_{,}$	Outputs enabled			1.5		1.5		1.5	mA
$\Delta I_{CC}^{\#}$	One input at 3.4 V,	Outputs disabled			50		50		50	μΑ
	Other inputs at $V_{CC}$ or GND	Control inputs			1.5		1.5		1.5	mA
Ci	V <sub>I</sub> = 2.5 V or 0.5 V			4						pF
Co	V <sub>O</sub> = 2.5 V or 0.5 V			8						pF

\* On products compliant to MIL-PRF-38535, this parameter does not apply.

<sup>†</sup> All typical values are at  $V_{CC} = 5$  V.

<sup>‡</sup> This parameter is characterized, but not production tested.

§ This data sheet limit may vary among suppliers.

 $\P$  Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

<sup>#</sup>This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.

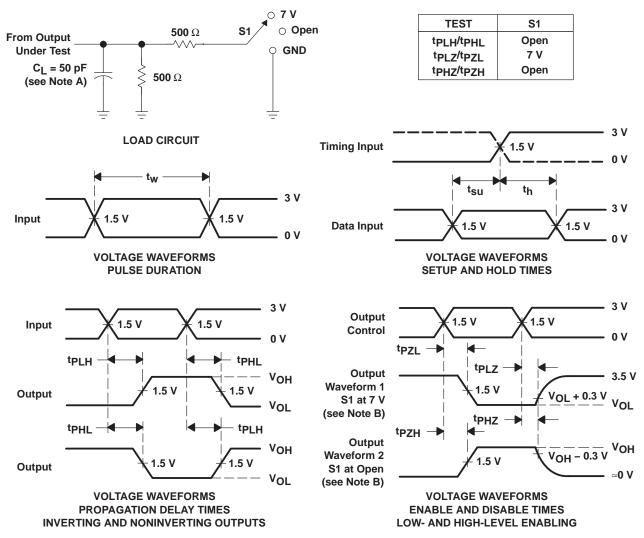
# switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM			V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C			BT827	SN74ABT827		UNIT
	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
<sup>t</sup> PLH	•	v	1.1	2.6	4.4	1.1	4.9	1.1	4.8	
<sup>t</sup> PHL	A	Y	1.1	2.3	4.1	1.1	4.8	1.1	4.7	ns
<sup>t</sup> PZH	1	v	1§	3.2	5.1	1	6	1§	5.9	
<sup>t</sup> PZL	OE	Y	1§	3.3	5.9	1	7.1	1§	6.9	ns
<sup>t</sup> PHZ	OE	v	2	4.9	6.3	2	7	2	6.8	
<sup>t</sup> PLZ	UE	Ť	1.3§	4.2	6.6	1.3	7.9	1.3§	6.9	ns

§ This data sheet limit may vary among suppliers.



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### PARAMETER MEASUREMENT INFORMATION

NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.

D. The outputs are measured one at a time, with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms





25-Oct-2016

# **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
5962-9450901QKA	ACTIVE	CFP	W	24	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9450901QK A SNJ54ABT827W	Samples
5962-9450901QLA	ACTIVE	CDIP	JT	24	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9450901QL A SNJ54ABT827JT	Samples
SN74ABT827DBLE	OBSOLETE	SSOP	DB	24		TBD	Call TI	Call TI	-40 to 85		
SN74ABT827DBR	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB827	Samples
SN74ABT827DW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT827	Samples
SN74ABT827DWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT827	Samples
SN74ABT827PW	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB827	Samples
SN74ABT827PWG4	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB827	Samples
SN74ABT827PWLE	OBSOLETE	TSSOP	PW	24		TBD	Call TI	Call TI	-40 to 85		
SN74ABT827PWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB827	Samples
SNJ54ABT827JT	ACTIVE	CDIP	JT	24	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9450901QL A SNJ54ABT827JT	Samples
SNJ54ABT827W	ACTIVE	CFP	W	24	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9450901QK A SNJ54ABT827W	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



25-Oct-2016

#### TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN54ABT827, SN74ABT827 :

Catalog: SN74ABT827

• Military: SN54ABT827

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

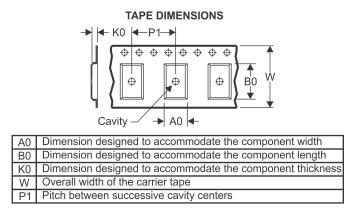
# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ABT827DBR	SSOP	DB	24	2000	330.0	16.4	8.2	8.8	2.5	12.0	16.0	Q1
SN74ABT827DWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
SN74ABT827PWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

26-Mar-2016

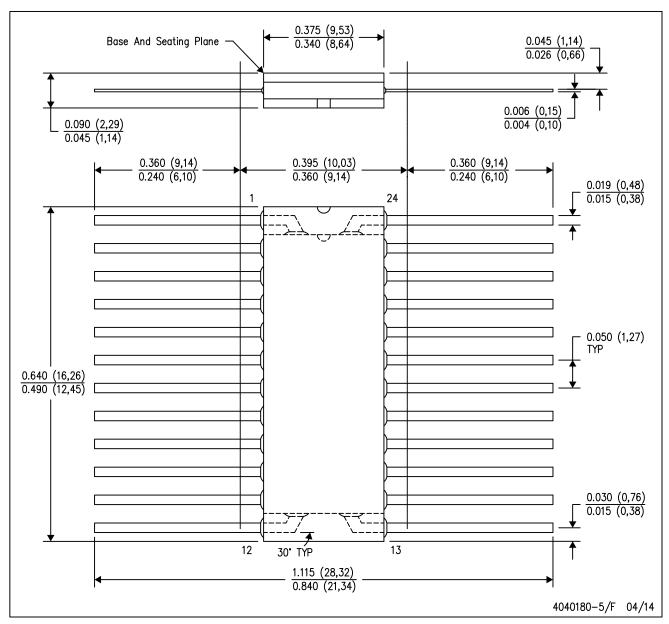


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ABT827DBR	SSOP	DB	24	2000	367.0	367.0	38.0
SN74ABT827DWR	SOIC	DW	24	2000	367.0	367.0	45.0
SN74ABT827PWR	TSSOP	PW	24	2000	367.0	367.0	38.0

CERAMIC DUAL FLATPACK

W (R-GDFP-F24)



NOTES: A. All linear dimensions are in inches (millimeters).

- This drawing is subject to change without notice. В.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
   E. Falls within Mil-Std 1835 GDFP2-F20



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



# LAND PATTERN DATA



NOTES:

A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 B. This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



# LAND PATTERN DATA



NOTES: Α. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
  C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# **MECHANICAL DATA**

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

# DB (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



# **MECHANICAL DATA**

MCER004A - JANUARY 1995 - REVISED JANUARY 1997

# JT (R-GDIP-T\*\*)

### **CERAMIC DUAL-IN-LINE**

24 LEADS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification.
- E. Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB



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